Notice of References Cited Application/Control No. 10/828,437 Examiner Rakesh K. Dhingra Applicant(s)/Patent Under Reexamination ENDOH ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0022293	09-2001	Maeda et al.	216/67
*	В	US-2002/0029745	03-2002	Nagaiwa et al.	118/723.00E
*	C	US-2003/0106647	06-2003	Koshiishi et al.	156/345.53
*	D	US-2003/0164226	09-2003	Kanno et al.	156/345.51
*	E	US-2001/0008172	07-2001	SHODA et al.	156/345
*	F	US-2004/0005726	01-2004	Huang, Chuan-Chieh	438/14
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q				<u> </u>	
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	Not 1 / Marie Document							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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